Search Notes

Application/Control No.	Applicant(s)/Patent und r Reexamination	
10/825,816	KIM ET AL.	
Examiner	Art Unit	
Chuc D. Tran	2821	

SEARCHED					
Class	Subclass	Date	Examiner		
359	344,337	5/30/2006	тс		
	-				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	l				
L					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
BRS		5/30/2006	тс